- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

The '107 contain two independent J-K flip-flops with individual J-K, clock, and direct clear inputs. The '107 is a positive pulse-triggered flip-flop. The J-K input data is loaded into the master while the clock is high and transferred to the slave and the outputs on the high-tolow clock transistion. For these devices the J and K inputs must be stable while the clock is high.

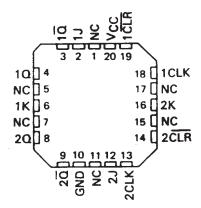
The 'LS107A contain two independent negative-edgetriggered flip-flops. The J and K inputs must be stable prior to the high-to-low clock transition for predictable operation. When the clear is low, it overrides the clock and data inputs forcing the Q output low and the \overline{Q} output high.

The SN54107 and the SN54LS107A are characterized for operation over the full military temperature range of -55 °C to 125 °C. The SN74107 and the SN74LS107A are characterized for operation from 0 °C to 70 °C.

| SN54107, SN54LS107A J PACKAGE |
|-------------------------------|
| SN74107 N PACKAGE |
| SN74LS107A D OR N PACKAGE |
| (TOP VIEW) |

| 1JC1 10C2 10C3 1KC4 20C5 20C6 | 12 11 10 | V <u>CC</u> 11CLR 11CLK 22K 22CLR 22CLR |
|--|----------------|--|
| | 9 8 | |

SN54LS107A . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

| | FUNCTION TABLE | | | | | | | | | | | | |
|-----|----------------|------|------|--------|----|--|--|--|--|--|--|--|--|
| | INPU | OUTF | PUTS | | | | | | | | | | |
| CLR | CLK | J | к | Q | ā | | | | | | | | |
| L | x | х | Х | L | н | | | | | | | | |
| н | n | L | L | 00 | ā0 | | | | | | | | |
| н | л | н | L | н | L | | | | | | | | |
| н | л | L | н | L | н | | | | | | | | |
| н | л | н | н | TOGGLE | | | | | | | | | |

107

'LS107A **FUNCTION TABLE** OUTPUTS INPUTS ā CLR CLK к α J х х L н Ł X ā₀ н L L **Q**0 L н н L H L 1 L, н н н ŧ. L н н TOGGLE н 1 ā₀ Н х х 00 н

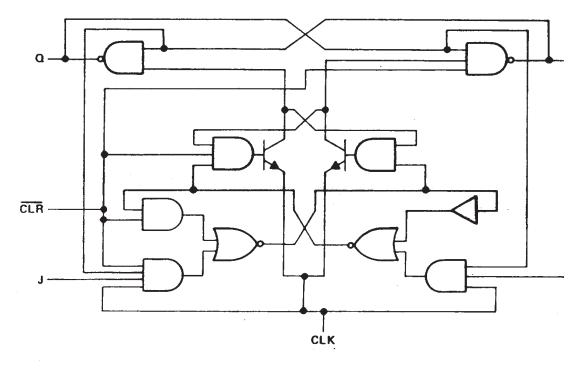
Copyright © 1988, Texas Instruments Incorporated

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard varranty. Production processing does not necessarily include testing of all parameters.

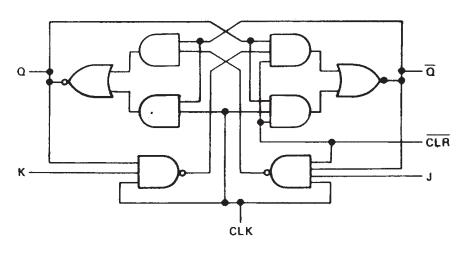


SN54107, SN54LS107A, SN74107, SN74LS107A DUAL J-K FLIP-FLOPS WITH CLEAR SDLS036 - DECEMBER 1983 - REVISED MARCH 1988

logic diagrams (positive logic)

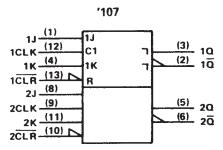


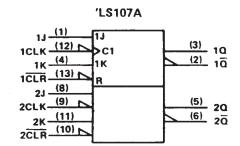






logic symbols[†]



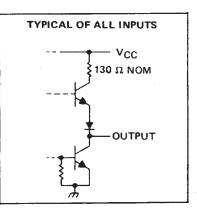


[†]These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for D, J, and N packages.

schematic of inputs and outputs

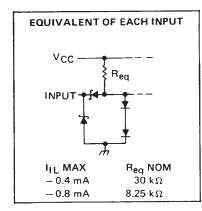
EQUIVALENT OF EACH INPUT

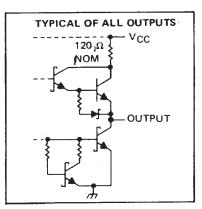
'107



.







absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

| Supply voltage, VCC (see Note 1) | |
|---|--|
| Input voltage: '107 | 5.5 V |
| | 7. |
| 'LS107A | ······································ |
| Operating free-air temperature range: SN54' | |
| SN74' | 0°C to 70°C |
| Storage temperature range | -65° C to 150° C |

NOTE 1: Voltage values are with respect to network ground terminal.



SDLS036 - DECEMBER 1983 - REVISED MARCH 1988

recommended operating conditions

| | | | | SN54107 | | | SN54107 SN74107 | | | |)7 | |
|----------------|---------------------------------|-------------------|------|---------|-----|------|-----------------|------|------|--|----|--|
| | | | MIN | NOM | MAX | MIN | NOM | MAX | UNIT | | | |
| Vcc | Supply voltage | | 4.5 | 5 | 5.5 | 4.75 | 5 | 5.25 | V | | | |
| VIH | High-level input voltage | | 2 | | | 2 | | | V | | | |
| VIL | Low-level input voltage | | | | 0.8 | | | 0.8 | V | | | |
| ЮН | High-level output current | | | - 0.4 | | | - 0.4 | mA | | | | |
| 10L | Low-level output current | • • • • • • • • • | | | 16 | | | 16 | mA | | | |
| | | CLK high | 20 | | | 20 | | | | | | |
| tw | Pulse duration | CLK low | 47 | | | 47 | | | ns | | | |
| | | CLR low | 25 | | | 25 | | | | | | |
| tsu | Input setup time before CLK1 | <u></u> | 0 | | | 0 | | | ns | | | |
| t _h | Input hold time-data after CLK1 | | 0 | | | 0 | | | กร | | | |
| TA | Operating free-air temperature | | - 55 | | 125 | 0 | | 70 | °C | | | |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS [†] | | | SN5410 | 7 | | SN7410 | 7 | | |
|----------------|-----------|------------------------------|------------------------|--------------------------|--------|-------|-------|--------|-------|-------|------|
| | AMETER | TEST CONDITIONS | | | MIN | TYP‡ | MAX | MIN | TYP‡ | MAX | UNIT |
| VIK | | V _{CC} = MIN, | l1 = - 12 mA | | | | - 1.5 | | | - 1.5 | V |
| ∨он | | V _{CC} = MIN, | V _{IH} = 2 V, | V _{IL} = 0.8 V, | 2.4 | 3.4 | | 2.4 | 3.4 | | v |
| •ОН | | ¹ OH = − 0.4 mA | | | 2.4 | 3.4 | | 2.4 | 3.4 | | ľ |
| VOL | | V _{CC} = MIN, | V _{IH} = 2 V, | V _{1L} = 0.8 V, | | 0.2 | 0.4 | | 0.2 | 0.4 | v |
| VOL | | I _{OL} = 16 mA | | | | 0.2 | 0.4 | | 0.2 | 0.4 | |
| ł _l | | V _{CC} = MAX, | V ₁ = 5.5 V | | | | 1 | | | 1 | mA |
| 1 | J or K | Vcc = MAX, | V ₁ = 2.4 V | | | | 40 | | | 40 | |
| Чн | All other | VCC - MAA, | V - 2.4 V | | | | 80 | | | 80 | μA |
| 1 | J or K | | | | | - 1.6 | | | - 1.6 | | |
| ΗL | All other | V _{CC} = MAX, | V _I = 0.4 V | | | | - 3.2 | | | - 3.2 | mA |
| los § | | V _{CC} = MAX | · | | - 20 | | - 57 | - 18 | | - 57 | mA |
| Icc1 | | V _{CC} = MAX, | See Note 2 | · · · | | 10 | 20 | | 10 | 20 | mA |

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡]All typical values are at V_{CC} = 5 V, T_A = 25 ° C.

[§]Not more than one output should be shorted at a time.

Average per flip-flop.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and \overline{Q} outputs high in turn. At the time of measurement, the clock input is grounded.

switching characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$ (see note 3)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | TEST CON | MIN | түр | MAX | UNIT | |
|------------------|-----------------|----------------|---------------------------------------|--------------------|-----|-----|------|-----|
| f _{max} | | | · · · · · · · · · · · · · · · · · · · | | 15 | 20 | | MHz |
| ^t PLH | CLR CLK | ā | | | | 16 | 25 | ns |
| ^t PHL | | Q | $R_L = 400 \Omega$, | C <u>L</u> ≈ 15 pF | | 25 | 40 | ns |
| ^t PLH | | | | | | 16 | 25 | ns |
| ^t PHL | | | | | | 25 | 40 | ns |

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



SN54LS107A, SN74LS107A DUAL J-K FLIP-FLOPS WITH CLEAR

SDLS036 - DECEMBER 1983 - REVISED MARCH 1988

recommended operating conditions

| | | | S | SN54LS107A SN74LS107A | | | 07A | | |
|--------|--------------------------------------|------------------|------|-----------------------|-------|------|-----|-------|------|
| | | M | | | | | NOM | MAX | UNIT |
| Vcc | Supply voltage | | 4.5 | 5 | 5.5 | 4.75 | 5 | 5.25 | V |
| VIH | High-level input voltage | | 2 | | | 2 | | | V |
| VIL | Low-level input voltage | | | | 0.7 | | | 8.0 | V |
| ЮН | High-level output current | | | - | - 0.4 | | | - 0.4 | mA |
| †OL | Low-level output current | | | | 4 | | | 8 | mA |
| fclock | Clock frequency | | 0 | | 30 | 0 | | 30 | MHz |
| | | CLK high | 20 | | | 20 | | | |
| tw | Pulse duration | CLR low | 25 | | : | 25 | | | ns |
| | | data high or low | 20 | | | 20 | | | |
| tsu | Setup time before CLK I CLR inactive | | 25 | | | 25 | | | ns |
| th | Hold time-data after CLK1 | | 0 | | | 0 | | | ns |
| TA | Operating free-air temperature | | - 55 | | 125 | 0 | | 70 | °C |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | | | uct | SN | 54LS10 |)7A | SN | 174LS10 | 07A | UNIT |
|-----------------|------------|--|--------------------------------|------------------------|------|--------|-------|------|---------|-------|------|
| | | TEST CONDITIONS [†] | | MIN | TYP‡ | MAX | MIN | TYP‡ | MAX | UNIT | |
| VIK | | V _{CC} = MIN, | l _l = – 18 mA | <u> </u> | | | - 1.5 | | | - 1.5 | V |
| ∨он | | V _{CC} = MIN, I _{OH} = 0.4 mA | V _{IH} = 2 V, | VIL = MAX, | 2.5 | 3.4 | | 2.7 | 3.4 | | v |
| V _{OL} | | V _{CC} = MIN, I _{OL} = 4 mA | VIL = MAX, | V _{IH} = 2 V, | | 0.25 | 0.4 | | 0.25 | 0.4 | v |
| | | V _{CC} = MIN, I _{OL} = 8 mA | VIL = MAX, | V _{IH} = 2 V, | | | | | 0.35 | 0.5 | v |
| | J or K | | | | | | 0.1 | | | 0.1 | |
| lj – | CLR | V _{CC} = MAX, | V ₁ = 7 V | | | | 0.3 | | | 0.3 | mA |
| | CLK | 1 | | | | | 0.4 | | | 0.4 | |
| | J or K | | | | | | 20 | | | 20 | |
| Чн | CLR | V _{CC} = MAX, | V ₁ = 2.7 V | 2.7 V | | | 60 | | | 60 | μA |
| | CLK | | | | | | 80 | | | 80 | |
| | J or K | | | | | | - 0.4 | | | - 0.4 | mA |
| 11 | CLR or CLK | VCC = MAX, | $V_{CC} = MAX$, $V_I = 0.4 V$ | | | | - 0.8 | | | - 0.8 | mA |
| los§ | • | V _{CC} = MAX, | See Note 4 | | - 20 | | - 100 | - 20 | | - 100 | mA |
| ICC (| Total) | V _{CC} = MAX, | See Note 2 | | | 4 | 6 | | 4 | 6 | mA |

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

 \ddagger All typical values are at V_{CC} = 5 V, T_A = 25°C.

§Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and Q, outputs high in turn. At the time of measurement, the clock input is grounded.

NOTE 4: For certain devices where state commutation can be caused by shorting an output to ground, an equivalent test may be performed with V_O = 2.25 V and 2.125 V for the 54 family and the 74 family, respectively, with the minimum and maximum limits reduced to one half of their stated values.

switching characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$ (see note 3)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | TEST CONDITIONS | MIN | түр | MAX | UNIT |
|------------------|-----------------|----------------|-----------------------------------|-----|-----|-----|------|
| fmax | | | | 30 | 45 | | MHz |
| ^t PLH | | | $R_L = 2 k\Omega$, $C_L = 15 pF$ | | 15 | 20 | ns |
| ^t PHL | CLR or CLK | | _ | | 15 | 20 | ns |

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1999, Texas Instruments Incorporated